

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Shunpei Yamazaki, et al. Art Unit : 2813
Serial No. : 09/451,665 Examiner : Laura Schillinger
Filed : November 30, 1999 Confirmation No.: 9359
Title : SEMICONDUCTOR DEVICE AND MANUFACTURING METHOD THEREOF

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

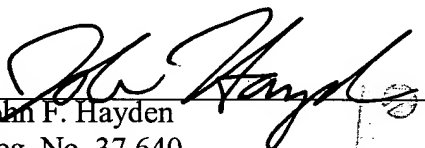
INFORMATION DISCLOSURE STATEMENT

Applicants submit the references listed on the attached form PTO-1449.

This statement is being filed after a final Office action, but before payment of the issue fee. Each item of information in this statement (i) was cited in an office action from a foreign patent office in a counterpart Japanese application, the communication being dated August 12, 2003, which is not more than three months prior to the filing of this statement, and (ii) was not first cited in any communication from a foreign patent office in a counterpart application which was more than three months prior to the filing date of this statement. Please charge Deposit Account No. 06-1050 in the amount of \$180 for payment of the late submission fee of \$1.17(p). Please apply any other charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,

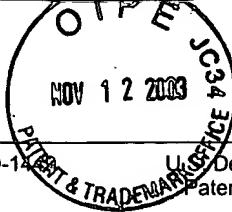
Date: November 12, 2003


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Substitute Form PTO-1449 (Modified) Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 07977-017002	Application No. 09/451,665
	Applicant Shunpei Yamazaki, et al.		
	Filing Date November 30, 1999		Group Art Unit 2813

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	5,594,371	01/14/1997	Douseki			06/27/1995
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AL	06-029834	02/04/1994	JAPAN			ABS	
	AM	08-228145	09/03/1996	JAPAN			ABS	
	AN	64-7559	01/11/1989	JAPAN			ABS	
	AO	EP 0 690 510 A1	01/03/1996	EUROPE			In English	
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
	AQ	
	AR	
	AS	
	AT	

Examiner Signature	Date Considered
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	